Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/082,081	LEE, CHULHEE
Examiner	Art Unit
Dave Czekaj	2613

SEARCHED			
Class	Subclass	Date	Examiner
375	240.01-07	6/24/2005	DC
	240.11-19		
	240.24		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		<del></del>	-

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Search Attached	6/24/2005	DC	
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